

<b>Notice of References Cited</b>	Application/Control No. 10/690,936	Applicant(s)/Patent Under Reexamination BADENELL, JON E.	
	Examiner NNENNA EKPO	Art Unit 2425	Page 1 of 1

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*	B	US-6,961,061	11-2005	Johnson et al.	345/473
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	K	US-			
	L	US-			
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**NON-PATENT DOCUMENTS**

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